

## DMOS FULL-BRIDGE MOTOR DRIVERS

Check for Samples: DRV8800, DRV8801

## **FEATURES**

- Low ON-Resistance [R<sub>ds(ON)</sub>] Outputs
- Overcurrent Protection
- Motor Lead Short-to-Supply Protection
- Short-to-Ground Protection
- Low-Power Mode
- Synchronous Rectification
- Diagnostic Output
- Internal Undervoltage Lockout (UVLO)

- Crossover-Current Protection
- 16-Pin QFN With PowerPAD™ Package

## **APPLICATIONS**

- Printers
- Industrial Automation

#### DESCRIPTION/ORDERING INFORMATION

Designed to control dc motors by using pulse width modulation (PWM), the DRV8800/DRV8801 is capable of peak output currents up to ±2.8 A and operating voltages up to 36 V.

The PHASE and ENABLE inputs provide dc motor speed and direction control by applying external pulse-width modulation (PWM) and control signals. Internal synchronous rectification control circuitry provides lower power dissipation during PWM operation.

Internal circuit protection includes motor lead short-to-supply/short-to-ground, thermal shutdown with hysteresis, undervoltage monitoring of VBB and VCP, and crossover-current protection.

The DRV8800/DRV8801 is supplied in a thin-profile 16-pin QFN (RTY) PowerPAD™ package, providing enhanced thermal dissipation. The devices are lead free (Pb free).

#### ORDERING INFORMATION

T <sub>A</sub>	PACKAGE <sup>(1)</sup> (2)	ORDERABLE PART NUMBER	TOP-SIDE MARKING		
		DRV8800RTYR	DRV8800		
	Plantic OFN 46 (S DOFD 46) DTV	DRV8800RTYT	DRV8800		
	Plastic QFN 16 (S-PQFP-16) – RTY	DRV8801RTYR	DRV8801		
–40°C to 85°C		DRV8801RTYT	DRV8801		
-40°C to 85°C		DRV8800PWP	DRV8800		
	TSSOP - PWP	DRV8800PWPR	DRV8800		
		DRV8801PWP	DRV8801		
		DRV8801PWPR	DRV8801		

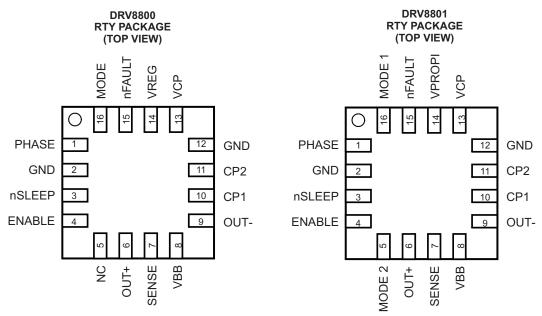
<sup>(1)</sup> For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

<sup>(2)</sup> Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



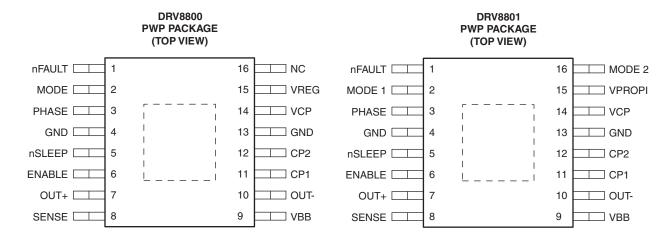


NC - Do not connect

## **TERMINAL FUNCTIONS**

	TERMINAL	-	
NO. NAME			DESCRIPTION
NO.	DRV8800	DRV8801	
1	PHASE	PHASE	Phase logic input for direction control
2	GND	GND	Ground
3	nSLEEP	nSLEEP	Sleep logic input
4	ENABLE	ENABLE	Enable logic input
5	NC	MODE 2	No connect (DRV8800), Mode 2 logic input (DRV8801)
6	OUT+	OUT+	DMOS full-bridge output positive
7	SENSE	SENSE	Sense power return
8	VBB	VBB	Load supply voltage
9	OUT-	OUT-	DMOS full-bridge output negative
10	CP1	CP1	Charge-pump capacitor 1
11	CP2	CP2	Charge-pump capacitor 2
12	GND	GND	Ground
13	VCP	VCP	Reservoir capacitor
14	VREG	VPROPI	Regulated voltage (DRV8800), Winding current proportional voltage output (DRV8801)
15	nFAULT	nFAULT	Fault open-drain output
16	MODE	MODE 1	Mode logic input
	PowerPAD	PowerPAD	Exposed pad for thermal dissipation connect to GND pins





NC - Do not connect

## **TERMINAL FUNCTIONS**

	TERMINA	L	
NO.	N/	AME	DESCRIPTION
NO.	DRV8800	DRV8801	
1	nFAULT	nFAULT	Fault open-drain output
2	MODE	MODE 1	Mode logic input
3	PHASE	PHASE	Logic input for direction control
4	GND	GND	Ground
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6	ENABLE	ENABLE	Enable logic input
7	OUT+	OUT+	DMOS full-bridge output positive
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9	VBB	VBB	Load supply voltage
10	OUT-	OUT-	DMOS full-bridge output negative
11	CP1	CP1	Charge-pump capacitor 1
12	CP2	CP2	Charge-pump capacitor 2
13	GND	GND	Ground
14	VCP	VCP	Reservoir capacitor
15	VREG	VPROPI	Regulated voltage (DRV8800), Winding current proportional voltage output (DRV8801)
16	NC	MODE 2	No connect (DRV8800), Mode 2 logic input (DRV8801)
	PowerPAD	PowerPAD	Exposed pad for thermal dissipation connect to GND pins

VDD (Optional) VREG may be left disconnected

VBB

22 uf
25V
1 uf
50V

PHASE

GND

PHASE

GND

DRV8800

CP2

SOV

OUT
H

GO

OUT
OUT-

100 uf 50V

.1 uf / 50V

Figure 1. DRV8800 TYPICAL APPLICATION DIAGRAM



Figure 2. DRV8801 TYPICAL APPLICATION DIAGRAM

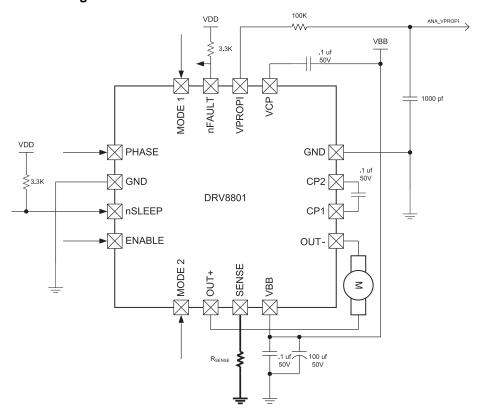


Figure 3. DRV8800 FUNCTIONAL BLOCK DIAGRAM

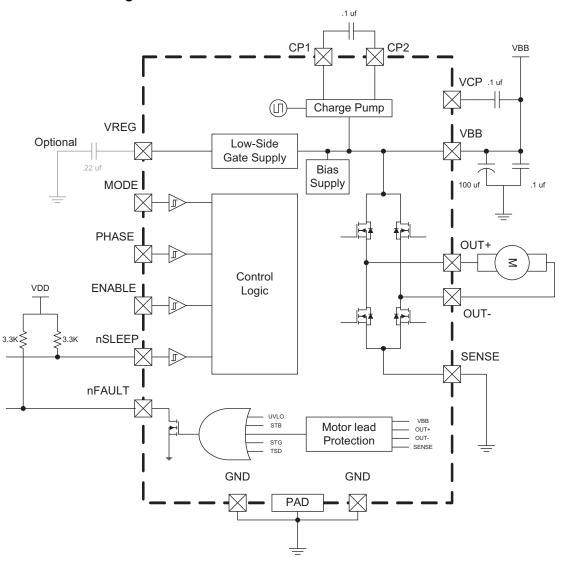
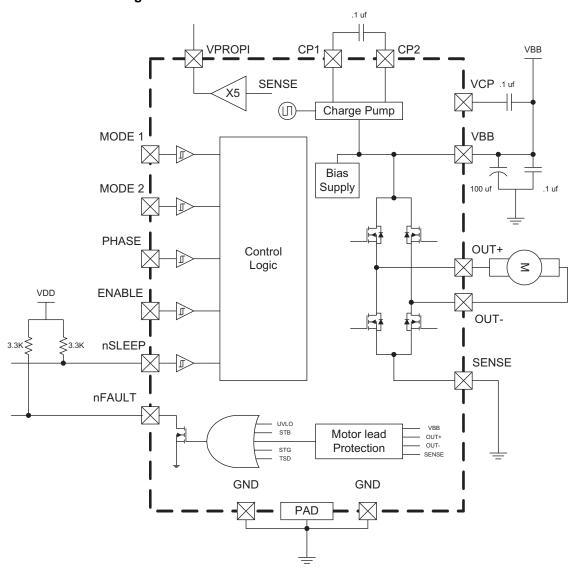




Figure 4. DRV8801 FUNCTIONAL BLOCK DIAGRAM





## **ABSOLUTE MAXIMUM RATINGS(1)**

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
VBB	Load supply voltage (2)		40	V
	Output current		2.8	Α
V <sub>Sense</sub>	Sense voltage		±500	mV
	VBB to OUTx		36	V
	OUTx to SENSE		36	V
VDD	Logic input voltage (2)	-0.3	7	V
CCD roting	Human-Body Model (HBM)		±2	kV
ESD rating	Charged-Device Model (CDM)		500	V
	Continuous total power dissipation	See THERMAL INFO	ORMA	TION Table
T <sub>A</sub>	Operating free-air temperature range	-40	85	°C
TJ	Maximum junction temperature		150	°C
T <sub>stg</sub>	Storage temperature range	-40	125	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values are with respect to network ground terminal.

#### THERMAL INFORMATION

		DRV8800/01	DRV8800/01	
	THERMAL METRIC	RTY	PWP	UNITS
		16 PINS	16 PINS	
$\theta_{JA}$	Junction-to-ambient thermal resistance <sup>(1)</sup>	38.1	43.9	
$\theta_{ m JCtop}$	Junction-to-case (top) thermal resistance (2)	36.7	30.8	
θ <sub>JB</sub>	Junction-to-board thermal resistance (3)	16.1	25.3	90044
ΨЈΤ	Junction-to-top characterization parameter <sup>(4)</sup>	0.3	1.1	°C/W
Ψјв	Junction-to-board characterization parameter <sup>(5)</sup>	16.2	25	
JCbot	Junction-to-case (bottom) thermal resistance <sup>(6)</sup>	4.1	5.6	

<sup>(1)</sup> The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as specified in JESD51-7, in an environment described in JESD51-2a.

#### RECOMMENDED OPERATING CONDITIONS

		MIN	NOM	MAX	UNIT
V <sub>IN</sub>	Input voltage, VBB	8	32	38	V
T <sub>A</sub>	Operating free-air temperature	-40		85	°C

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<sup>(2)</sup> The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDEC-standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.

<sup>(3)</sup> The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.

<sup>(4)</sup> The junction-to-top characterization parameter, ψ<sub>JT</sub>, estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ<sub>JA</sub>, using a procedure described in JESD51-2a (sections 6 and 7).

<sup>(5)</sup> The junction-to-board characterization parameter, ψ<sub>JB</sub>, estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ<sub>JA</sub>, using a procedure described in JESD51-2a (sections 6 and 7).

<sup>(6)</sup> The junction-to-case (bottom) thermal resistance is obtained by simulating a cold plate test on the exposed (power) pad. No specific JEDEC standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.



## **ELECTRICAL CHARACTERISTICS**

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
		f <sub>PWM</sub> < 50 kHz		6		A
ВВ	Motor supply current	Charge pump on, Outputs disabled		3.2		mA
		Sleep mode			10	μΑ
V <sub>IH</sub>	PHASE, ENABLE,		2			
V <sub>IL</sub>	MODE input voltage				0.8	V
/ <sub>IH</sub>	a CL EED in a strong to a c		2.7			V
/ <sub>IL</sub>	nSLEEP input voltage				0.8	V
IH	DUACE MODE involve comment	V <sub>IN</sub> = 2 V		<1.0	20	
IL	PHASE, MODE input current	V <sub>IN</sub> = 0.8 V	-20	≤–2.0	20	μΑ
IH	ENIARI E innut ourrent	V <sub>IN</sub> = 2 V		40	100	
IL	ENABLE input current	V <sub>IN</sub> = 0.8 V		16	40	μΑ
IH	act CCD input ourrent	V <sub>IN</sub> = 2.7 V		27	50	
IL	nSLEEP input current	V <sub>IN</sub> = 0.8 V		<1	10	μΑ
V <sub>OL</sub>	nFAULT output voltage	I <sub>sink</sub> = 1 mA			0.4	V
/BBNFR	VBB nFAULT release	8 V < VBB < 40 V		12	13.8	V
/ <sub>IHys</sub>	Input hysteresis, except nSLEEP		100	500	800	mV
		Source driver, I <sub>OUT</sub> = −2.8 A, T <sub>J</sub> = 25°C		0.48		
2	Output ON registance	Source driver, I <sub>OUT</sub> = −2.8 A, T <sub>J</sub> = 125°C		0.74	0.85	Ω
$R_{ds(ON)}$	Output ON resistance	Sink driver, I <sub>OUT</sub> = 2.8 A, T <sub>J</sub> = 25°C		0.35		12
		Sink driver, I <sub>OUT</sub> = 2.8 A, T <sub>J</sub> = 125°C		0.52	0.7	
VTRP	RSENSE voltage trip	SENSE connected to ground through a $0.2-\Omega$ resistor		500		mV
/ <sub>f</sub>	Rody diada farward valtaga	Source diode, $I_f = -2.8 \text{ A}$			1.4	V
⁄f	Body diode forward voltage	Sink diode, I <sub>f</sub> = 2.8 A			1.4	V
	Drangation delay time	PWM, Change to source or sink ON		600		
pd	Propagation delay time	PWM, Change to source or sink OFF		100		ns
COD	Crossover delay			500		ns
DAGain	Differential AMP gain	Sense = 0.1 V to 0.4 V		5		V/V
Protection	Circuitry					
/UV	UVLO threshold	VBB increasing		6.5	7.5	V
OCP	Overcurrent threshold		3			Α
OCP	Overcurrent protection period			1.2		ms
ΓJW	Thermal warning temperature	Temperature increasing <sup>(1)</sup>		160		°C
TJTSD	Thermal shutdown temperature	Temperature increasing <sup>(2)</sup>		175		°C

<sup>(1)</sup> Once the device reaches the thermal warning temperature of 160°C, the device will remain in thermal warning until the device cools to

<sup>145°</sup>C. This is known as the device's thermal warning hysteresis.

Once the device reaches the thermal shutdown temperature of 175°C, the device will remain in thermal shutdown until the device cools to 160°C. This is known as the device's thermal shutdown hysteresis.

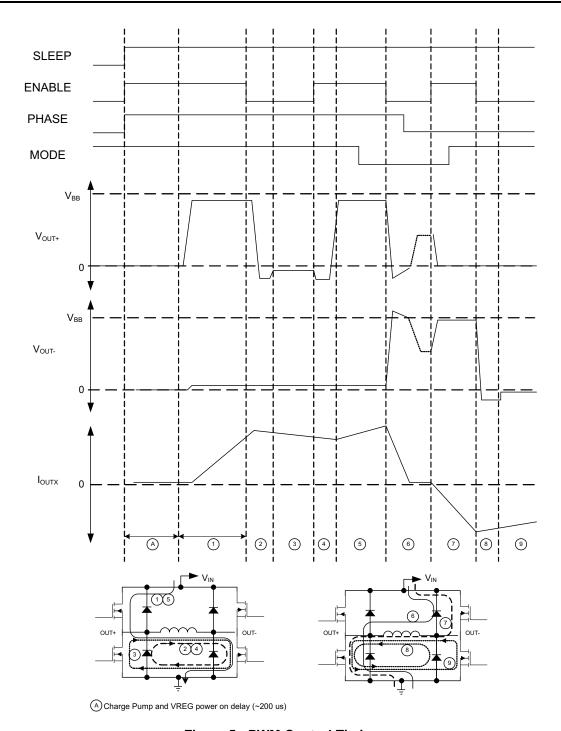


Figure 5. PWM Control Timing



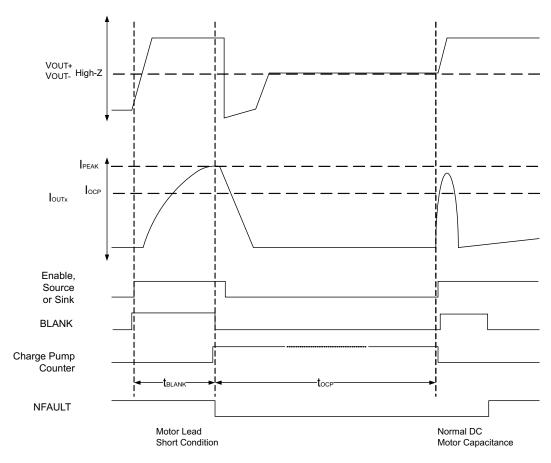


Figure 6. Overcurrent Control Timing

#### **FUNCTIONAL DESCRIPTION**

## **Device Operation**

The DRV8800/DRV8801 is designed to drive one dc motor. The current through the output full-bridge switches and all N-channel DMOS are regulated with a fixed off-time PWM control circuit.

## **Logic Inputs**

It is recommended to use a high-value pullup resistor when logic inputs are pulled up to  $V_{DD}$ . This resistor limits the current to the input in case an overvoltage event occurs. Logic inputs are nSLEEP, MODE, PHASE, and ENABLE. Voltages higher than 7 V on any logic input can cause damage to the input structure.

## VREG (DRV8800 Only)

This output represents a measurement of the internal regulator voltage. This pin should be left disconnected. A voltage of approximately 7.5 V can be measured at this pin.

## VPROPI (DRV8801 Only)

This output offers an analog voltage proportional to the winding current. Voltage at this terminal is five times greater than the motor winding current (VPROPI = 5xl). VPROPI is meaningful only if there is a resistor connected to the SENSE pin. If SENSE is connected to ground, VPROPI measures 0 V. During slow decay, VPROPI outputs 0 V. VPROPI can output a maximum of 2.5 V, since at 500 mV on SENSE, the H-bridge is disabled.



## **Charge Pump**

The charge pump is used to generate a supply above VBB to drive the source-side DMOS gates. A  $0.1-\mu F$  ceramic monolithic capacitor should be connected between CP1 and CP2 for pumping purposes. A  $0.1-\mu F$  ceramic monolithic capacitor, CStorage, should be connected between VCP and VBB to act as a reservoir to run the high-side DMOS devices. The VCP voltage level is internally monitored and, in the case of a fault condition, the outputs of the device are disabled.

#### **Shutdown**

As a measure to protect the device, faults caused by very high junction temperatures or low voltage on VCP disable the outputs of the device until the fault condition is removed. At power on, the UVLO circuit disables the drivers

#### **Low-Power Mode**

Control input nSLEEP is used to minimize power consumption when the DRV8800/DRV8801 is not in use. This disables much of the internal circuitry, including the internal voltage rails and charge pump. nSLEEP is asserted low. A logic high on this input pin results in normal operation. When switching from low to high, the user should allow a 1-ms delay before applying PWM signals. This time is needed for the charge pump to stabilize.

- MODE 1 (MODE on the DRV8800)
   Input MODE 1 is used to toggle between fast-decay mode and slow-decay mode. A logic high puts the device in slow-decay mode.
- MODE 2 (DRV8801 only)
   MODE 2 is used to select which set of drivers (high side versus low side) is used during the slow-decay recirculation. MODE 2 is meaningful only when MODE 1 is asserted high. A logic high on MODE 2 has current recirculation through the high-side drivers. A logic low has current recirculation through the low-side

#### **Braking**

drivers.

The braking function is implemented by driving the device in slow-decay mode (MODE 1 pin is high) and deasserting the enable to low. Because it is possible to drive current in both directions through the DMOS switches, this configuration effectively shorts out the motor-generated BEMF as long as the ENABLE chop mode is asserted. The maximum current can be approximated by VBEMF/RL. Care should be taken to ensure that the maximum ratings of the device are not exceeded in worse-case braking situations – high-speed and high-inertia loads.

## **Diagnostic Output**

The nFAULT pin signals a problem with the chip via an open-drain output. A motor fault, undervoltage condition, or  $T_J > 160^{\circ}\text{C}$  drives the pin low. This output is not valid when nSLEEP puts the device into minimum power dissipation mode (i.e., nSLEEP is low). nFAULT stays asserted (nFAULT = L) until VBB reaches VBBNFR to give the charge pump headroom to reach its undervoltage threshold. nFAULT is a status-only signal and does not affect any device functionality. The H-bridge portion still operates normally down to VBB = 8 V with nFAULT asserted.

#### Thermal Shutdown (TSD)

Two die-temperature monitors are integrated on the chip. As die temperature increases toward the maximum, a thermal warning signal is triggered at 160°C. This fault drives the nFAULT low, but does not disable the operation of the chip. If the die temperature increases further, to approximately 175°C, the full-bridge outputs are disabled until the internal temperature falls below a hysteresis of 15°C.

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## Control Logic Table<sup>(1)</sup>

			-									
ODEDATION	PINS											
OPERATION	OUT-	OUT+	nSLEEP	MODE 2	MODE 1	ENABLE	PHASE					
Forward	L	Н	1	X	Х	1	1					
Reverse	Н	L	1	X	X	1	0					
Brake (slow decay)	L	L	1	0	1	0	Х					
Brake (slow decay)	Н	Н	1	1	1	0	Χ					
Fast-decay synchronous rectification (2)	Н	L	1	х	0	0	1					
Fast-decay synchronous rectification (2)	L	Н	1	х	0	0	0					
Sleep mode	Z	Z	0	Х	Х	X	Х					

<sup>(1)</sup> X = Don't care, Z = high impedance

#### **Overcurrent Protection**

The current flowing through the high-side and low-side drivers is monitored to ensure that the motor lead is not shorted to supply or ground. If a short is detected, the full-bridge outputs are turned off, flag nFAULT is driven low, and a 1.2-ms fault timer is started. After this 1.2-ms period,  $t_{\rm OCP}$ , the device is then allowed to follow the input commands and another turnon is attempted (nFAULT becomes high again during this attempt). If there is still a fault condition, the cycle repeats. If after  $t_{\rm OCP}$  expires it is determined the short condition is not present, normal operation resumes and nFAULT is deasserted.

<sup>(2)</sup> To prevent reversal of current during fast-decay synchronous rectification, outputs go to the high-impedance state as the current approaches 0 A.



#### **APPLICATION INFORMATION**

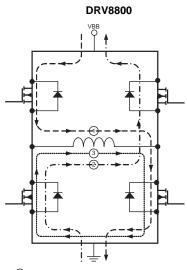
## **Power Dissipation**

First-order approximation of power dissipation in the DRV8800/DRV8801 can be calculated by examining the power dissipation in the full-bridge during each of the operation modes. DRV8800/DRV8801 utilize synchronous rectification. During the decay cycle, the body diode is shorted by the low- $R_{ds(ON)}$  driver, which in turn reduces power dissipation in the full-bridge. In order to prevent shoot through (high-side and low-side drivers on the same side are ON at the same time), DRV8800/DRV8801 implement a 500-ns typical crossover delay time. During this period, the body diode in the decay current path conducts the current until the DMOS driver turns on. High current and high ambient temperature applications should take this into consideration. In addition, motor parameters and switching losses can add power dissipation that could affect critical applications.

#### **Drive Current**

This current path is through the high-side sourcing DMOS driver, motor winding, and low-side sinking DMOS driver. Power dissipation I<sup>2</sup>R losses in one source and one sink DMOS driver, as shown in Equation 1.

$$P_D = I^2 (R_{DS(on)Source} + R_{DS(onSink)})$$
 (1)



- 1 Drive Current
- 2 Fast decay with synchronous rectification (reverse)
- 3 Slow decay with synchronous rectification (brake)



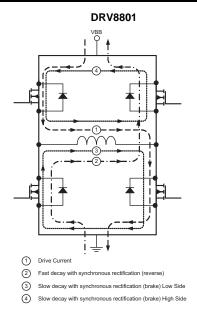


Figure 7. Current Path

## **Fast Decay With Synchronous Rectification**

This decay mode is equivalent to a phase change where the opposite drivers are switched on. When in fast decay, the motor current is not allowed to go negative (direction change). Instead, as the current approaches zero, the drivers turn off. The power calculation is the same as the drive current calculation (see Equation 1).

Product Folder Links: DRV8800 DRV8801



## Slow-Decay SR (Brake Mode)

In slow-decay mode, both low-side sinking drivers turn on, allowing the current to circulate through the H-bridge's low side (two sink drivers) and the load. Power dissipation I2R loses in the two sink DMOS drivers:

$$P_D = I^2 (2 \times R_{DS(on)Sink}) \tag{2}$$

## **SENSE**

A low-value resistor can be placed between the SENSE pin and ground for current-sensing purposes. To minimize ground-trace IR drops in sensing the output current level, the current-sensing resistor should have an independent ground return to the star ground point. This trace should be as short as possible. For low-value sense resistors, the IR drops in the PCB can be significant, and should be taken into account.

#### **NOTE**

When selecting a value for the sense resistor, SENSE does not exceed the maximum voltage of ±500 mV. The H-bridge is disabled and enters recirculation when any current in the motor windings generates a SENSE voltage greater than or equal to 500 mV.

#### Ground

A ground power plane should be located as close to the DRV8800/DRV8801 as possible. The copper ground plane directly under the thermal pad makes a good location. This pad can then be connected to ground for this purpose.

## Layout

The printed circuit board (PCB) should use a heavy ground plane. For optimum electrical and thermal performance, the DRV8800/DRV8801 must be soldered directly onto the board. On the underside of the DRV8800/DRV8801 is a thermal pad, which provides a path for enhanced thermal dissipation. The thermal pad should be soldered directly to an exposed surface on the PCB. Thermal vias are used to transfer heat to other layers of the PCB. For more information on this technique, please refer to document SLMA002.

The load supply pin, VBB, should be decoupled with an electrolytic capacitor (typically 100  $\mu$ F) in parallel with a ceramic capacitor placed as close as possible to the device. The ceramic capacitors between VCP and VBB, connected to VREG, and between CP1 and CP2 should be as close to the pins of the device as possible, in order to minimize lead inductance.





## **REVISION HISTORY**

C	hanges from Revision G (October 2013) to Revision H	Page
•	Changed maximum junction temperature from 190°C to 150°C	8
•	Changed VTRP description/test conditions	9
•	Changed Protection Circuitry section	9
•	Changed Note in SENSE section	16





28-Oct-2013

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
DRV8800PWP	ACTIVE	HTSSOP	PWP	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	DRV8800	Samples
DRV8800PWPR	ACTIVE	HTSSOP	PWP	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	DRV8800	Samples
DRV8800RTYR	ACTIVE	QFN	RTY	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	DRV 8800	Samples
DRV8800RTYT	ACTIVE	QFN	RTY	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	DRV 8800	Samples
DRV8801PWP	ACTIVE	HTSSOP	PWP	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	DRV8801	Samples
DRV8801PWPR	ACTIVE	HTSSOP	PWP	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	DRV8801	Samples
DRV8801RTYR	ACTIVE	QFN	RTY	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	DRV 8801	Samples
DRV8801RTYT	ACTIVE	QFN	RTY	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	DRV 8801	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



## PACKAGE OPTION ADDENDUM

28-Oct-2013

- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF DRV8801:

Automotive: DRV8801-Q1

NOTE: Qualified Version Definitions:

Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

## PACKAGE MATERIALS INFORMATION

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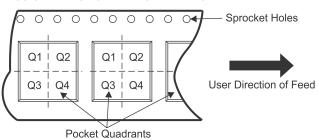
## TAPE AND REEL INFORMATION





		Dimension designed to accommodate the component width
		Dimension designed to accommodate the component length
		Dimension designed to accommodate the component thickness
	W	Overall width of the carrier tape
ľ	P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



## \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DRV8800PWPR	HTSSOP	PWP	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
DRV8800RTYT	QFN	RTY	16	250	180.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
DRV8801PWPR	HTSSOP	PWP	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
DRV8801RTYT	QFN	RTY	16	250	180.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2

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\*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DRV8800PWPR	HTSSOP	PWP	16	2000	367.0	367.0	35.0
DRV8800RTYT	QFN	RTY	16	250	210.0	185.0	35.0
DRV8801PWPR	HTSSOP	PWP	16	2000	367.0	367.0	35.0
DRV8801RTYT	QFN	RTY	16	250	210.0	185.0	35.0

PWP (R-PDSO-G16)

# PowerPAD™ PLASTIC SMALL OUTLINE



NOTES:

- All linear dimensions are in millimeters.
- This drawing is subject to change without notice.
- Body dimensions do not include mold flash or protrusions. Mold flash and protrusion shall not exceed 0.15 per side.
- This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <a href="http://www.ti.com">www.ti.com</a>.

  E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- E. Falls within JEDEC MO-153

PowerPAD is a trademark of Texas Instruments.



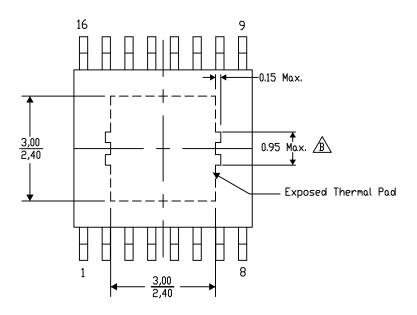
# PWP (R-PDSO-G16) PowerPAD™ SMALL PLASTIC OUTLINE

#### THERMAL INFORMATION

This PowerPAD<sup>™</sup> package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Top View

Exposed Thermal Pad Dimensions

4206332-8/AG 08/13

NOTE: A. All linear dimensions are in millimeters

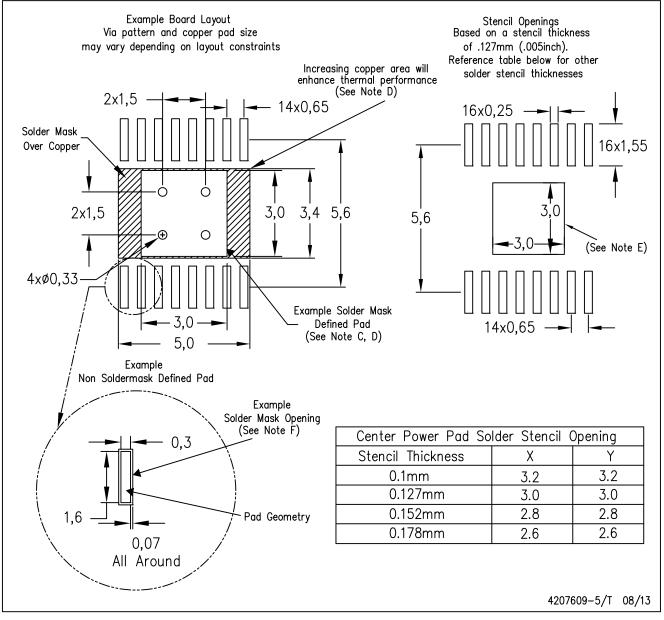
Exposed tie strap features may not be present.

PowerPAD is a trademark of Texas Instruments



# PWP (R-PDSO-G16)

# PowerPAD™ PLASTIC SMALL OUTLINE



#### NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="http://www.ti.com">http://www.ti.com</a>. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
- F. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



RTY (S-PWQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5-1994.

- B. This drawing is subject to change without notice.
- C. Quad Flatpack, No-leads (QFN) package configuration.

The package thermal pad must be soldered to the board for thermal and mechanical performance.

See the Product Data Sheet for details regarding the exposed thermal pad dimensions.

E. Falls within JEDEC MO-220.



# RTY (S-PWQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: A. All linear dimensions are in millimeters

# RTY (S-PWQFN-N16)

# PLASTIC QUAD FLATPACK NO-LEAD



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="http://www.ti.com">http://www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for solder mask tolerances.



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